


<i>Search Notes</i> 	Application/Control No. 10565106	Applicant(s)/Patent Under Reexamination HAN ET AL.
	Examiner M. Lee	Art Unit 2622

SEARCHED			
Class	Subclass	Date	Examiner
348	515, 518, 484	2/19/09	ml

SEARCH NOTES		
Search Notes	Date	Examiner
east	2/19/09	ml

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner

	/M. Lee/ Primary Examiner.Art Unit 2622
--	--